Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/693,150	BAUGH ET AL.		
Examiner	Art Unit		
Paul Dinh	2825		

	SEARCHED					
Class	Subclass	Date	Examiner			
716	1, 4,8-9	12/5/2005	PD			
716	12-13	12/5/2005	PD			
		i				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
) 				

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST, IEEE	12/5/2005	PD